Search Notes

Application/Control No.	Applicant(s Reexamina
10/602 882	MATSUUF

Applicant(s)/Patent under Reexamination

10/602,882

Examiner

MATSUURA ET AL.

Art Unit

Daniel Tekle

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	SEARCHED					
Class	Subclass	Date	Examiner			
386	46	3/16/2007	DT			
386	125	3/16/2007	DT			
369	13.16	3/16/2007	. DT			
369	13.25	3/16/2007	DT			
360	57	3/16/2007	DT			
360	66	3/16/2007	DT			
360	69	3/16/2007	DT			

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) AND SEARCH QUERY IS ATTACHED	3/16/2007	DT		
COMBINED CITATION AND NPL	3/16/2007	DT		
INVENTOR SEARCH	3/16/2007	DT		
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